


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/520,744	EGAWA, YOSUKE	
	Examiner	Art Unit	
	Vivian Chen	1773	

ISSUE CLASSIFICATION												
ORIGINAL					CROSS REFERENCE(S)							
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)						
264		331.11			428	212	480					
INTERNATIONAL CLASSIFICATION					264	173.11	173.12	173.15	173.16	210.1	241	280
B	3	2	B	37/14	264	285	288.4	291	299	319	330	331.21
B	3	2	B	37/15	156	244.11	244.24					
B	3	2	B	37/16								
B	3	2	B	38/00								
B	3	2	B	7/00								

_____ (Assistant Examiner) (Date)		_____ Vivian Chen Primary Examiner (Primary Examiner) (Date) 9/10/07		Total Claims Allowed: 6	
_____ (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. ---

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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